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Report No.: SZEM150700425803
Page: 1 of 8

RF Exposure Evaluation Report

Application No.: SZEM1507004258CR
Applicant: SHENZHEN Hitevision Technology Co., Ltd.
Manufacturer: Newline Interactive Inc.
Factory: SHENZHEN Hitevision Technology Co., Ltd.
Product Name: Collaboration Touch Screen
Model No.(EUT): X7
Add Model No.: X7-x, X7-xx, X7-xxx (x =0-9, a-z or A-Z)
FCC ID: 2ACYT-BNL15X7
Standards: 47 CFR Part 1.1307 (2014)
47 CFR Part 1.1310 (2014)
Date of Receipt: 2015-07-20
Date of Test: 2015-08-27 to 2015-09-02
Date of Issue: 2015-09-07

Test Result :	PASS*
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* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Jack Zhang
EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

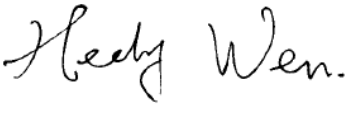
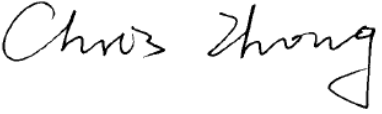
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2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
00		2015-09-07		Original

Authorized for issue by:			
			
			2015-09-02
Tested By		(Eric Fu) /Project Engineer	Date
			
			2015-09-07
Prepared By		(Hedy Wen) /Clerk	Date
			
			2015-09-07
Checked By		(Chris Zhong) /Reviewer	Date



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4 General Information

4.1 Client Information

Applicant:	SHENZHEN Hitevision Technology Co., Ltd.
Address of Applicant:	No. 8, Qinglan 1st Road, Pingshan, Shenzhen, Guangdong 518118, P. R. China.
Manufacturer:	Newline Interactive Inc.
Address of Manufacturer:	101 East Park Blvd. Suite 807 Plano, TX 75074, USA
Factory:	SHENZHEN Hitevision Technology Co., Ltd.
Address of Factory:	No. 8, Qinglan 1st Road, Pingshan, Shenzhen, Guangdong 518118, P. R. China.

4.2 General Description of EUT

Product Name:	Collaboration Touch Screen
Model No.:	X7
Operation Frequency:	IEEE 802.11b/g/n(HT20): 2412MHz to 2462MHz IEEE 802.11n(HT40): 2422MHz to 2452MHz
Channel Numbers:	IEEE 802.11b/g, IEEE 802.11n(HT20): 11 Channels IEEE 802.11n(HT40): 7 Channels
Channel Separation:	5MHz
Type of Modulation:	IEEE for 802.11b: DSSS(CCK,DQPSK,DBPSK) IEEE for 802.11g : OFDM(64QAM, 16QAM, QPSK, BPSK) IEEE for 802.11n(HT20 and HT40) : OFDM (64QAM, 16QAM, QPSK, BPSK)
Sample Type:	Fixed production
Test Power Grade:	11B : 40 ; 11G :45 ; 11N : 45 (manufacturer declare)
Antenna Gain:	3dBi
Power Supply:	Input voltage: AC100-240V 50/60Hz Max 4.5A DC 3V (1.5V*2 Size "AAA" battery) for remote control

Remark:

Model No.: X7, X7-x, X7-xx, X7-xxx (x =0-9, a-z or A-Z)

Only the model X7 was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, only different on outlook silkprint, color and model number.



4.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch E&E Lab

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

4.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **VCCI**

The 10m Semi-anechoic chamber and Shielded Room (7.5m x 4.0m x 3.0m) of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

- **FCC – Registration No.: 556682**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

- **Industry Canada (IC)**

The 3m Semi-anechoic chambers of SGS-CSTC Standards Technical Services Co., Ltd. have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-2.



4.5 Deviation from Standards

None.

4.6 Abnormalities from Standard Conditions

None.

4.7 Other Information Requested by the Customer

None.



5 RF Exposure Evaluation

5.1 RF Exposure Compliance Requirement

5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3–3.0	614	1.63	*(100)	6
3.0–30	1842/f	4.89/f	*(900/f ²)	6
30–300	61.4	0.163	1.0	6
300–1500			f/300	6
1500–100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f ²)	30
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500–100,000			1.0	30

F= Frequency in MHz

Friis Formula

Friis transmission formula: $P_d = (P_{out} * G) / (4 * \pi * R^2)$

Where

P_d = power density in mW/cm²

P_{out} = output power to antenna in mW

G = gain of antenna in linear scale

π = 3.1416

R = distance between observation point and center of the radiator in cm

P_d is the limit of MPE, 1 mW/cm². If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance r where the MPE limit is reached.

5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.



4.1.3 EUT RF Exposure Evaluation

Antenna Gain: 3dBi

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 2.00 in linear scale.

Output Power Into Antenna & RF Exposure Evaluation Distance:

Channel	Frequency (MHz)	Max Conducted Peak Output Power (dBm)	Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm ²)	Limit	Result
Middle	2437	19.23	83.75	0.033	1.0	PASS

Note: Refer to report No. SZEM150700425802 for EUT test Max Conducted Peak Output Power value.

The distancer (4th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.